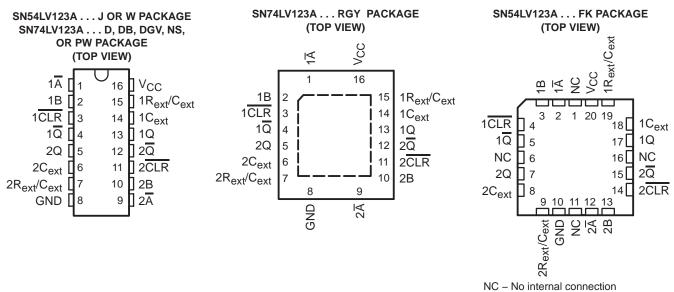
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- 2-V to 5.5-V V_{CC} Operation
- Max t_{pd} of 11 ns at 5 V
- Typical V_{OLP} (Output Ground Bounce)
 <0.8 V at V_{CC} = 3.3 V, T_A = 25°C
- Typical V_{OHV} (Output V_{OH} Undershoot)
 >2.3 V at V_{CC} = 3.3 V, T_A = 25°C
- Support Mixed-Mode Voltage Operation on All Ports
- Schmitt-Trigger Circuitry on A, B, and CLR Inputs for Slow Input Transition Rates
- Edge Triggered From Active-High or Active-Low Gated Logic Inputs

- I_{off} Supports Partial-Power-Down Mode Operation
- Retriggerable for Very Long Output Pulses, up to 100% Duty Cycle
- Overriding Clear Terminates Output Pulse
- Glitch-Free Power-Up Reset on Outputs
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)



description/ordering information

The 'LV123A devices are dual retriggerable monostable multivibrators designed for 2-V to 5.5-V V_{CC} operation.

These edge-triggered multivibrators feature output pulse-duration control by three methods. In the first method, the \overline{A} input is low and the B input goes high. In the second method, the B input is high and the \overline{A} input goes low. In the third method, the \overline{A} input is low, the B input is high, and the clear (\overline{CLR}) input goes high.

The output pulse duration is programmable by selecting external resistance and capacitance values. The external timing capacitor must be connected between C_{ext} and R_{ext}/C_{ext} (positive) and an external resistor connected between R_{ext}/C_{ext} and V_{CC} . To obtain variable pulse durations, connect an external variable resistance between R_{ext}/C_{ext} and V_{CC} . The output pulse duration also can be reduced by taking \overline{CLR} low.

Pulse triggering occurs at a particular voltage level and is not directly related to the transition time of the input pulse. The \overline{A} , B, and \overline{CLR} inputs have Schmitt triggers with sufficient hysteresis to handle slow input transition rates with jitter-free triggering at the outputs.

Once triggered, the basic pulse duration can be extended by retriggering the gated low-level-active (\overline{A}) or high-level-active (B) input. Pulse duration can be reduced by taking \overline{CLR} low. The input/output timing diagram illustrates pulse control by retriggering the inputs and early clearing.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



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description/ordering information (continued)

During power up, Q outputs are in the low state, and \overline{Q} outputs are in the high state. The outputs are glitch free, without applying a reset pulse.

These devices are fully specified for partial-power-down applications using Ioff. The Ioff circuitry disables the outputs, preventing damaging current backflow through the devices when they are powered down.

Pin assignments for these devices are identical to those of the 'AHC123A and 'AHCT123A devices for interchangeability, when allowed.

ORDERING INFORMATION

TA	PACK	AGE†	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	QFN – RGY	Reel of 1000	SN74LV123ARGYR	LV123A
	2010 D	Tube of 40	SN74LV123AD	11/4004
	SOIC - D	Reel of 2500	SN74LV123ADR	LV123A
	SOP - NS	Reel of 2000	SN74LV123ANSR	74LV123A
-40°C to 85°C	SSOP - DB	Reel of 2000	SN74LV123ADBR	LV123A
	Tube of 90 SN74LV123APW		SN74LV123APW	
	TSSOP – PW	Reel of 2000	SN74LV123APWR	LV123A
		Reel of 250	SN74LV123APWT	
	TVSOP - DGV	Reel of 2000	SN74LV123ADGVR	LV123A
	CDIP – J	Tube of 25	SNJ54LV123AJ	SNJ54LV123AJ
–55°C to 125°C	CFP – W	Tube of 150	SNJ54LV123AW	SNJ54LV123AW
	LCCC - FK	Tube of 55	SNJ54LV123AFK	SNJ54LV123AFK

[†]Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE (each multivibrator)

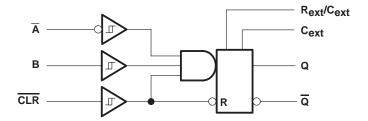
	INPUTS	i	OUTI	PUTS
CLR	Ā	В	Q	Q
L	Χ	Х	L	Н
Х	Н	X	∟‡	H [‡]
Х	Χ	L	L‡	H [‡]
Н	L	\uparrow	Л	T
Н	\downarrow	Н	Л	T
1	L	Н	Л	T

[‡]These outputs are based on the assumption that the indicated steady-state conditions at the $\overline{\mathsf{A}}$ and B inputs have been set up long enough to complete any pulse started before the setup.

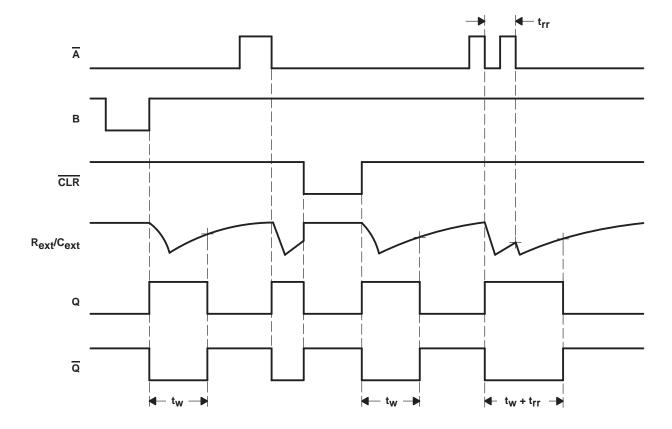


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logic diagram, each multivibrator (positive logic)



input/output timing diagram



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absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage range, V _{CC} –0.5 V to 7	
Input voltage range, V _I (see Note 1) –0.5 V to 7	7 V
Voltage range applied to any output in the high-impedance	
or power-off state, V _O (see Note 1)	7 V
Output voltage range in high or low state, V _O (see Notes 1 and 2)0.5 V to V _{CC} + 0.5	
Output voltage range in power-off state, V _O (see Note 1) –0.5 V to 7	7 V
Input clamp current, I_{IK} ($V_I < 0$)	
Output clamp current, I _{OK} (V _O < 0)	mΑ
Continuous output current, I_O ($V_O = 0$ to V_{CC})	mΑ
Continuous current through V _{CC} or GND ±50 m	mΑ
Package thermal impedance, θ_{JA} (see Note 3): D package	
(see Note 3): DB package 82°C/	
(see Note 3): DGV package	
(see Note 3): NS package	
(see Note 3): PW package)/W
(see Note 4): RGY package	
Storage temperature range, T _{stg}	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.
 - 2. This value is limited to 5.5 V maximum.
 - 3. The package thermal impedance is calculated in accordance with JESD 51-7.
 - 4. The package thermal impedance is calculated in accordance with JESD 51-5.



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recommended operating conditions (see Note 5)

			SN54L	V123A	SN74L	V123A	
			MIN	MAX	MIN	MAX	UNIT
Vcc	Supply voltage		2	5.5	2	5.5	V
		V _{CC} = 2 V	1.5		1.5		
	LPak Inval Construction	V _{CC} = 2.3 V to 2.7 V	V _{CC} ×0.7		$V_{CC} \times 0.7$] ,,
VIH	High-level input voltage	$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$	V _{CC} × 0.7		$V_{CC} \times 0.7$		V
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	V _{CC} × 0.7		$V_{CC} \times 0.7$		
		V _{CC} = 2 V		0.5		0.5	
.,		V _{CC} = 2.3 V to 2.7 V		$V_{CC} \times 0.3$		$V_{CC} \times 0.3$] ,,
V_{IL}	Low-level input voltage	V _{CC} = 3 V to 3.6 V		V _{CC} ×0.3		V _{CC} ×0.3	V
		V _{CC} = 4.5 V to 5.5 V		V _{CC} × 0.3		V _{CC} ×0.3	
VI	Input voltage		0	5.5	0	5.5	V
Vo	Output voltage		0	⁴ √VCC	0	VCC	V
		V _{CC} = 2 V		-50		-50	μΑ
		V _{CC} = 2.3 V to 2.7 V	2	-2		-2	
ІОН	High-level output current	V _{CC} = 3 V to 3.6 V	0	-6		-6	mA
		V _{CC} = 4.5 V to 5.5 V	Q	-12		-12	
		V _{CC} = 2 V		50		50	μΑ
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		2		2	
lOL	Low-level output current	V _{CC} = 3 V to 3.6 V		6		6	mA
		V _{CC} = 4.5 V to 5.5 V		12		12	
_		V _{CC} = 2 V	5k		5k		
R _{ext}	External timing resistance	V _{CC} ≥ 3 V	1k		1k		Ω
C _{ext}	External timing capacitance		No res	striction	No res	triction	pF
Δt/ΔV _{CC}	Power-up ramp rate		1		1		ms/V
TA	Operating free-air temperature		-55	125	-40	85	°C

NOTE 5: Unused R_{ext}/C_{ext} terminals should be left unconnected. All remaining unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

		TEST COMPLETIONS	.,,	SN54	1LV123A		SN74	LV123A	1	
PA	RAMETER	TEST CONDITIONS	vcc	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
		I _{OH} = -50 μA	2 V to 5.5 V	V _{CC} -0.1			V _{CC} -0.1			
		I _{OH} = -2 mA	2.3 V	2			2			.,
VOH		$I_{OH} = -6 \text{ mA}$	3 V	2.48			2.48			V
		I _{OH} = -12 mA	4.5 V	3.8			3.8			
		I _{OL} = 50 μA	2 V to 5.5 V			0.1			0.1	
.,		I _{OL} = 2 mA	2.3 V			0.4			0.4	V
VOL		I _{OL} = 6 mA	3 V		, s	0.44			0.44	V
		I _{OL} = 12 mA	4.5 V		,S	0.55			0.55	
	R _{ext} /C _{ext} †	V _I = 5.5 V or GND	2 V to 5.5 V		PA	±2.5			±2.5	
Ц	A B and OLB	V. FFV or CND	0	ć	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	±1			±1	μΑ
	A, B, and CLR	$V_I = 5.5 \text{ V or GND}$	0 to 5.5 V	70		±1			±1	
ICC	Quiescent	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V	000		20			20	μΑ
			2.3 V	Q.		220			220	
١.	Active state	$V_I = V_{CC}$ or GND,	3 V			280			280	•
ICC	(per circuit)	$R_{ext}/C_{ext} = 0.5 V_{CC}$	4.5 V			650			650	μΑ
			5.5 V			975			975	
l _{off}		V_I or $V_O = 0$ to 5.5 V	0						5	μΑ
<u> </u>		V. V or CND	3.3 V		1.9			1.9		~ F
Ci		$V_I = V_{CC}$ or GND	5 V		1.9			1.9		pF

[†] This test is performed with the terminal in the off-state condition.

timing requirements over recommended operating free-air temperature range, V_{CC} = 2.5 V \pm 0.2 V (unless otherwise noted) (see Figure 1)

				TEST CONDITIONS		T _A = 25°C			SN54LV123A		SN74LV123A	
			I IEST CC	ONDITIONS	MIN	TYP	MAX	MIN	MAX	MIN	MIN MAX	
	Pulse	CLR			6			6.5	A	6.5		
τ _W	duration	A or B trigger]		6			6.5	N. N	6.5		ns
	Dulas natri		D 410	C _{ext} = 100 pF	‡	94		Ф	1/2	‡		ns
trr	Pulse retrigger time Rext = 1		$R_{ext} = 1 k\Omega$	C _{ext} = 0.01 μF	‡	2		¢‡		‡		μS

[‡] See retriggering data in the application information section.

timing requirements over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

			TEOT 00	NIDITIONO	T _A = 25°C			SN54LV123A		SN74LV123A		UNIT
			l lesi cc	ONDITIONS	MIN	TYP	MAX	MIN	MAX	MIN	MIN MAX	
	Pulse	CLR			5			5		5		
t _W	duration	A or B trigger	1		5			5	704	5		ns
	Dulas asta		D 410	C _{ext} = 100 pF	‡	76		Φ	1110	‡		ns
τrr	Pulse retrigger time		$R_{ext} = 1 k\Omega$	C _{ext} = 0.01 μF	‡	1.8		*		‡		μS

[‡] See retriggering data in the application information section.



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timing requirements over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

			TEOT 00	TEST CONDITIONS		T _A = 25°C			SN54LV123A		/123A	LINUT
			TEST CC	SNOTTIONS	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
	Pulse	CLR			5			5	<i>A</i>	5		
t _W	duration	A or B trigger]		5			5	N. W	5		ns
	Dulaa satsi		D 410	C _{ext} = 100 pF	†	59		9	1/1	†		ns
t _{rr}	Pulse retri	gger ume	$R_{ext} = 1 k\Omega$	C _{ext} = 0.01 μF	†	1.5		QŤ.		†	·	μs

[†] See retriggering data in the application information section.

switching characteristics over recommended operating V_{CC} = 2.5 V \pm 0.2 V (unless otherwise noted) (see Figure 1) free-air temperature

	FROM	то	TEST	T,	_A = 25°C	;	SN54L\	/123A	SN74L	/123A	
PARAMETER	(INPUT)	(OUTPUT)	CONDITIONS	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
	Ā or B	Q or $\overline{\mathbb{Q}}$			14.5*	31.4*	1*	37*	1	37	
t _{pd}	CLR	Q or Q	C _L = 15 pF		13*	25*	1*	29.5*	1	29.5	ns
	CLR trigger	Q or Q			15.1*	33.4*	1*	39*	1	39	
	A or B	Q or Q			16.6	36	1	42	1	42	
t _{pd}	CLR	Q or Q	C _L = 50 pF		14.7	32.8	1	34.5	1	34.5	ns
•	CLR trigger	Q or Q			17.4	38	1 2	44	1	44	
			$C_L = 50 \text{ pF},$ $C_{ext} = 28 \text{ pF},$ $R_{ext} = 2 \text{ k}\Omega$		197	260	Jongo	320		320	ns
t _W ‡		Q or $\overline{\mathbb{Q}}$	$C_L = 50 \text{ pF},$ $C_{\text{ext}} = 0.01 \mu\text{F},$ $R_{\text{ext}} = 10 k\Omega$	90	100	110	90	110	90	110	μs
			$C_L = 50 \text{ pF},$ $C_{ext} = 0.1 \mu\text{F},$ $R_{ext} = 10 k\Omega$	0.9	1	1.1	0.9	1.1	0.9	1.1	ms
∆t _W §			C _L = 50 pF		±1						%

^{*} On products compliant to MIL-PRF-38535, this parameter is not production tested.



 $[\]ddagger$ t_W = Duration of pulse at Q and \overline{Q} outputs \S Δ t_W = Output pulse-duration variation (Q and \overline{Q}) between circuits in same package

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switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

DADAMETED	FROM	то	TEST	T,	_A = 25°C	;	SN54L\	/123A	SN74L	V123A	
PARAMETER	(INPUT)	(OUTPUT)	CONDITIONS	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
	A or B	Q or Q			10.2*	20.6*	1*	24*	1	24	
^t pd	CLR	Q or Q	C _L = 15 pF		9.3*	15.8*	1*	18.5*	1	18.5	ns
	CLR trigger	Q or Q			10.6*	22.4*	1*	26*	1	26	
	Ā or B	Q or Q			11.8	24.1	1	27.5	1	27.5	
^t pd	CLR	Q or Q	C _L = 50 pF		10.5	19.3	1	22	1	22	ns
	CLR trigger	Q or Q			12.3	25.9	1 8	29.5	1	29.5	
			$C_L = 50 \text{ pF},$ $C_{ext} = 28 \text{ pF},$ $R_{ext} = 2 \text{ k}\Omega$		182	240	Jongo	300		300	ns
t _W †		Q or $\overline{\mathbb{Q}}$	$C_L = 50 \text{ pF},$ $C_{ext} = 0.01 \mu\text{F},$ $R_{ext} = 10 k\Omega$	90	100	110	90	110	90	110	μs
	$C_L = 50 \mathrm{g}$ $C_{\text{ext}} = 0.1$	$C_L = 50 \text{ pF},$ $C_{ext} = 0.1 \mu\text{F},$ $R_{ext} = 10 k\Omega$	0.9	1	1.1	0.9	1.1	0.9	1.1	ms	
∆t _W ‡			$C_L = 50 pF$		±1						%

^{*} On products compliant to MIL-PRF-38535, this parameter is not production tested.

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

DADAMETED	FROM	то	TEST	T,	չ = 25°C	;	SN54L\	/123A	SN74L	V123A	LINUT
PARAMETER	(INPUT)	(OUTPUT)	CONDITIONS	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
	A or B	Q or Q			7.1*	12*	1*	14*	1	14	
^t pd	CLR	Q or Q	C _L = 15 pF		6.5*	9.4*	1*	11*	1	11	ns
	CLR trigger	Q or Q			7.4*	12.9*	1*	15*	1	15	
	Ā or B	Q or Q			8.3	14	1	16	1	16	
^t pd	CLR	Q or Q	C _L = 50 pF		7.4	11.4	1	13	1	13	ns
	CLR trigger	Q or Q			8.7	14.9	1 8	17	1	17	
			$C_L = 50 \text{ pF},$ $C_{ext} = 28 \text{ pF},$ $R_{ext} = 2 \text{ k}\Omega$		167	200	JONGO	240		240	ns
_{tw} †		Q or $\overline{\mathbb{Q}}$	$C_L = 50 \text{ pF},$ $C_{ext} = 0.01 \mu\text{F},$ $R_{ext} = 10 k\Omega$	90	100	110	90	110	90	110	μs
			$C_L = 50 \text{ pF},$ $C_{ext} = 0.1 \mu\text{F},$ $R_{ext} = 10 k\Omega$	0.9	1	1.1	0.9	1.1	0.9	1.1	ms
∆t _W ‡					±1						%

^{*} On products compliant to MIL-PRF-38535, this parameter is not production tested.



 $[\]dagger t_W = Duration of pulse at Q and <math>\overline{Q}$ outputs

 $[\]ddagger \Delta t_W = \text{Output pulse-duration variation (Q and } \overline{Q})$ between circuits in same package

 $[\]dagger t_W = Duration of pulse at Q and <math>\overline{Q}$ outputs

 $[\]ddagger \Delta t_W = \text{Output pulse-duration variation (Q and } \overline{Q} \text{)}$ between circuits in same package

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operating characteristics, T_A = 25°C

	PARAMETER	TEST CONDITIONS V _{CC}		TYP	UNIT	
	Bosses discharges and other	0 50 - 5	(40 MIL-	3.3 V	44	
pd	Power dissipation capacitance	$C_L = 50 \text{ pF},$	f = 10 MHz	5 V	49	pF

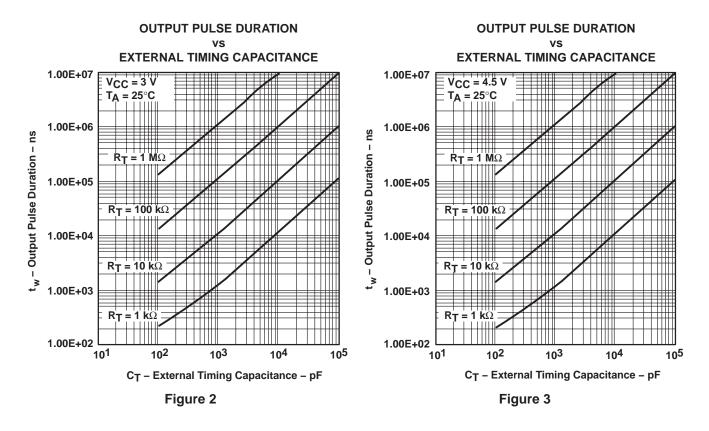
PARAMETER MEASUREMENT INFORMATION From Output Test Point **Under Test VCC** Inputs or 50% V_{CC} (see Note A) Outputs . 0 V **VOLTAGE WAVEFORMS LOAD CIRCUIT PULSE DURATION** Input A 50% V_{CC} (see Note B) Input CLR 50% V_CC (see Note B) VCC Input B 0 V 50% V_CC (see Note B) **tPHL** - V_{OH} In-Phase 50% V_{CC} VOH 50% V_{CC} In-Phase Output 50% V_{CC} - V_{OL} Output ^tPHL **tPLH** tPHL -· VOH Out-of-Phase Out-of-Phase 50% V_{CC} 50% V_{CC} 50% V_CC Output Output VOL VOL **VOLTAGE WAVEFORMS VOLTAGE WAVEFORMS DELAY TIMES DELAY TIMES**

NOTES: A. C_L includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \Omega$, $t_f = 3 \text{ ns}$, $t_f = 3 \text{ ns}$.
- C. The outputs are measured one at a time, with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

APPLICATION INFORMATION[†]



[†] Operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied.



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APPLICATION INFORMATION[†]

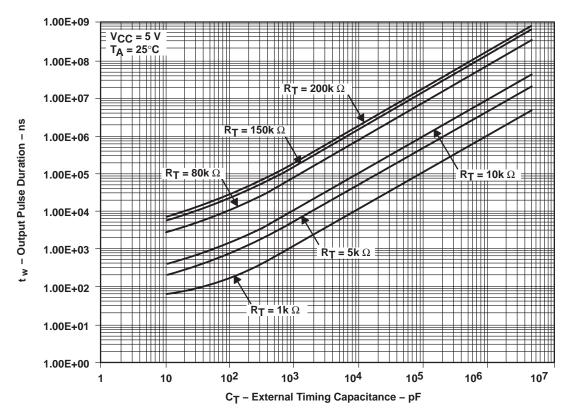


Figure 4. Output Pulse Duration vs External Timing Capacitance

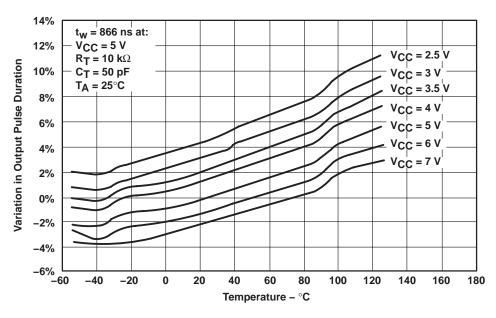
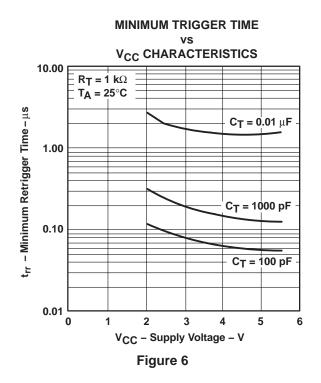


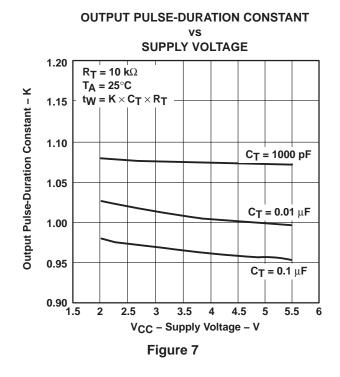
Figure 5. Variations in Output Pulse Duration vs Temperature

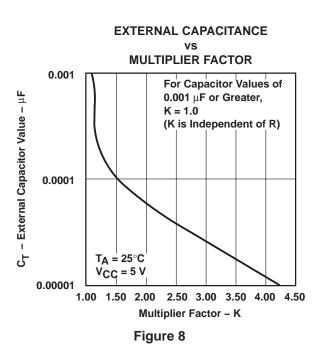
[†] Operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied.

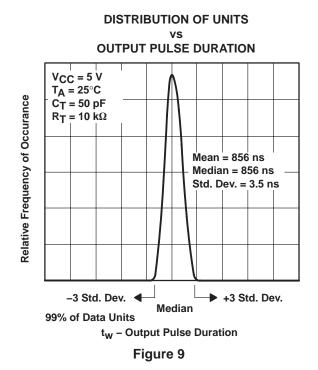


APPLICATION INFORMATION[†]









[†] Operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied.



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APPLICATION INFORMATION

caution in use

To prevent malfunctions due to noise, connect a high-frequency capacitor between V_{CC} and GND, and keep the wiring between the external components and C_{ext} and R_{ext}/C_{ext} terminals as short as possible.

power-down considerations

Large values of C_{ext} can cause problems when powering down the 'LV123A devices because of the amount of energy stored in the capacitor. When a system containing this device is powered down, the capacitor can discharge from V_{CC} through the protection diodes at pin 2 or pin 14. Current through the input protection diodes must be limited to 30 mA; therefore, the turn-off time of the V_{CC} power supply must not be faster than $t = V_{CC} \times C_{ext}/30$ mA. For example, if $V_{CC} = 5$ V and $C_{ext} = 15$ pF, the V_{CC} supply must turn off no faster than $t = (5 \text{ V}) \times (15 \text{ pF})/30$ mA = 2.5 ns. Usually, this is not a problem because power supplies are heavily filtered and cannot discharge at this rate. When a more rapid decrease of V_{CC} to zero occurs, the 'LV123A devices can sustain damage. To avoid this possibility, use external clamping diodes.

output pulse duration

The output pulse duration, t_W , is determined primarily by the values of the external capacitance (C_T) and timing resistance (R_T). The timing components are connected as shown in Figure 10.

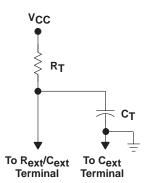


Figure 10. Timing-Component Connections

The pulse duration is given by:

$$t_{w} = K \times R_{T} \times C_{T}$$
 if C_{T} is \geq 1000 pF, $K = 1.0$ or

where:

tw = pulse duration in ns

 R_T = external timing resistance in $k\Omega$

if C_T is <1000 pF, K can be determined from Figure 8

C_T = external capacitance in pF

K = multiplier factor

Equation 1 and Figure 3 can be used to determine values for pulse duration, external resistance, and external capacitance.



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APPLICATION INFORMATION

retriggering data

The minimum input retriggering time (t_{MIR}) is the minimum time required after the initial signal before retriggering the input. After t_{MIR} , the device retriggers the output. Experimentally, it also can be shown that to retrigger the output pulse, the two adjacent input signals should be t_{MIR} apart, where $t_{MIR} = 0.30 \times t_{w}$. The retrigger pulse duration is calculated as shown in Figure 11.

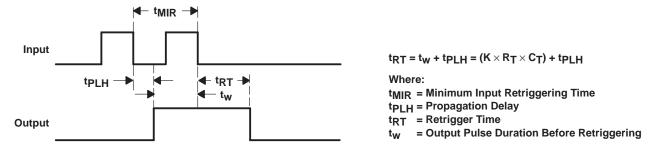
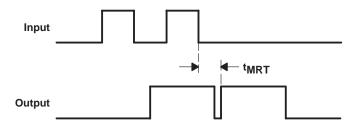


Figure 11. Retrigger Pulse Duration

The minimum value from the end of the input pulse to the beginning of the retriggered output should be approximately 15 ns to ensure a retriggered output (see Figure 12).



 t_{MRT} = Minimum Time Between the End of the Second Input Pulse and the Beginning of the Retriggered Output t_{MRT} = 15 ns

Figure 12. Input/Output Requirements





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PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
SN74LV123AD	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123ADBR	ACTIVE	SSOP	DB	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123ADBRE4	ACTIVE	SSOP	DB	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123ADBRG4	ACTIVE	SSOP	DB	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123ADE4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123ADG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123ADGVR	ACTIVE	TVSOP	DGV	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123ADGVRE4	ACTIVE	TVSOP	DGV	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123ADGVRG4	ACTIVE	TVSOP	DGV	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123ADR	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123ADRE4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123ADRG4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123ANSR	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123ANSRE4	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123ANSRG4	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123APW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123APWE4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123APWG4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123APWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123APWRE4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123APWRG4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123APWT	ACTIVE	TSSOP	PW	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123APWTE4	ACTIVE	TSSOP	PW	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123APWTG4	ACTIVE	TSSOP	PW	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV123ARGYR	ACTIVE	VQFN	RGY	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR



PACKAGE OPTION ADDENDUM

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Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins Pa	ackage Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
SN74LV123ARGYRG4	ACTIVE	VQFN	RGY	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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OTHER QUALIFIED VERSIONS OF SN74LV123A:

Automotive: SN74LV123A-Q1

Enhanced Product: SN74LV123A-EP

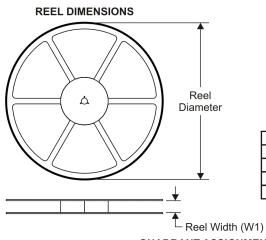
NOTE: Qualified Version Definitions:

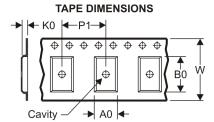
- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Enhanced Product Supports Defense, Aerospace and Medical Applications

PACKAGE MATERIALS INFORMATION

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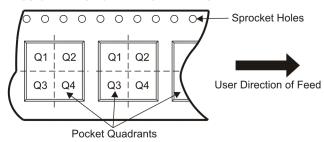
TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

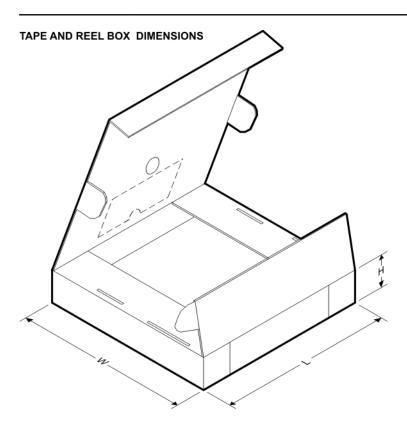
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LV123ADBR	SSOP	DB	16	2000	330.0	16.4	8.2	6.6	2.5	12.0	16.0	Q1
SN74LV123ADGVR	TVSOP	DGV	16	2000	330.0	12.4	6.8	4.0	1.6	8.0	12.0	Q1
SN74LV123ADR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
SN74LV123ANSR	SO	NS	16	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
SN74LV123APWR	TSSOP	PW	16	2000	330.0	12.4	7.0	5.6	1.6	8.0	12.0	Q1
SN74LV123ARGYR	VQFN	RGY	16	3000	180.0	12.4	3.8	4.3	1.5	8.0	12.0	Q1

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*All dimensions are nominal

All ulliletisions are nominal							
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LV123ADBR	SSOP	DB	16	2000	346.0	346.0	33.0
SN74LV123ADGVR	TVSOP	DGV	16	2000	346.0	346.0	29.0
SN74LV123ADR	SOIC	D	16	2500	333.2	345.9	28.6
SN74LV123ANSR	SO	NS	16	2000	346.0	346.0	33.0
SN74LV123APWR	TSSOP	PW	16	2000	346.0	346.0	29.0
SN74LV123ARGYR	VQFN	RGY	16	3000	190.5	212.7	31.8

DB (R-PDSO-G**)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

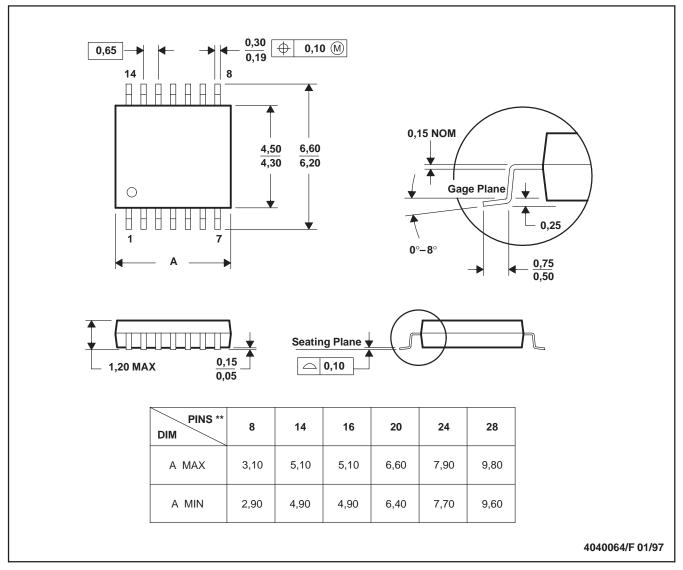
C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-150

PW (R-PDSO-G**)

14 PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE

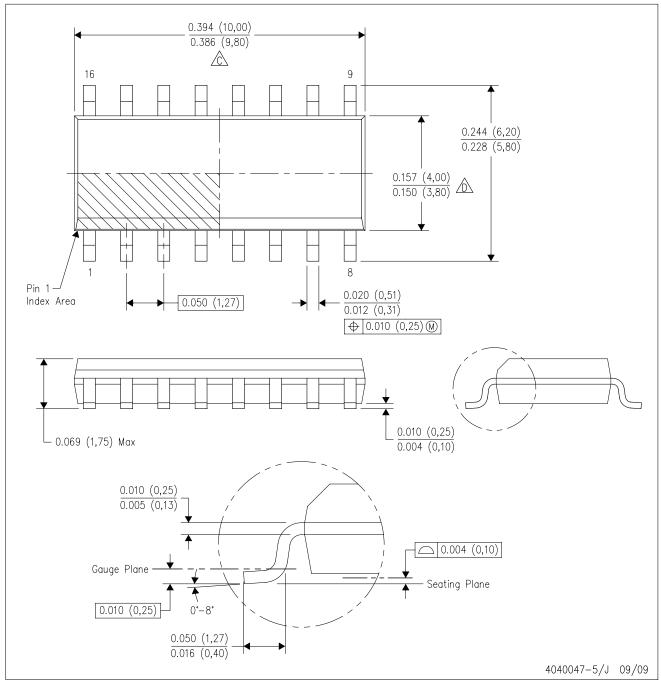


- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



D (R-PDS0-G16)

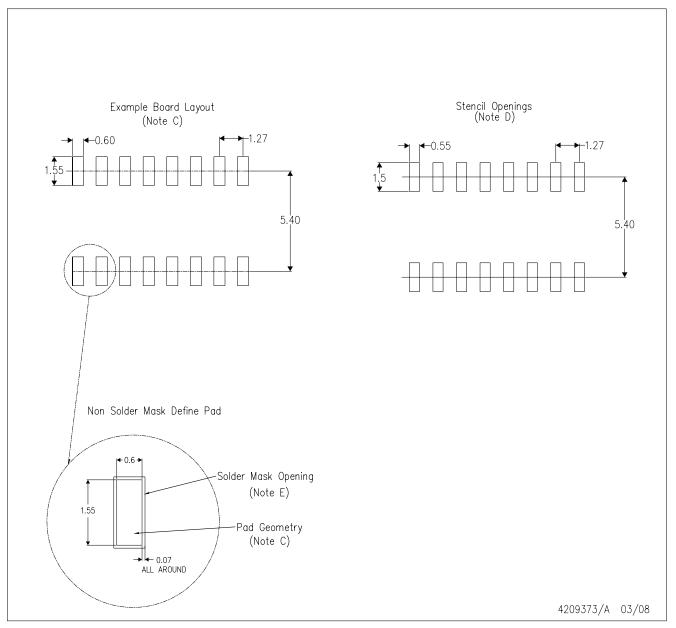
PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 (0,15) per end.
- Body width does not include interlead flash. Interlead flash shall not exceed .017 (0,43) per side.
- E. Reference JEDEC MS-012 variation AC.

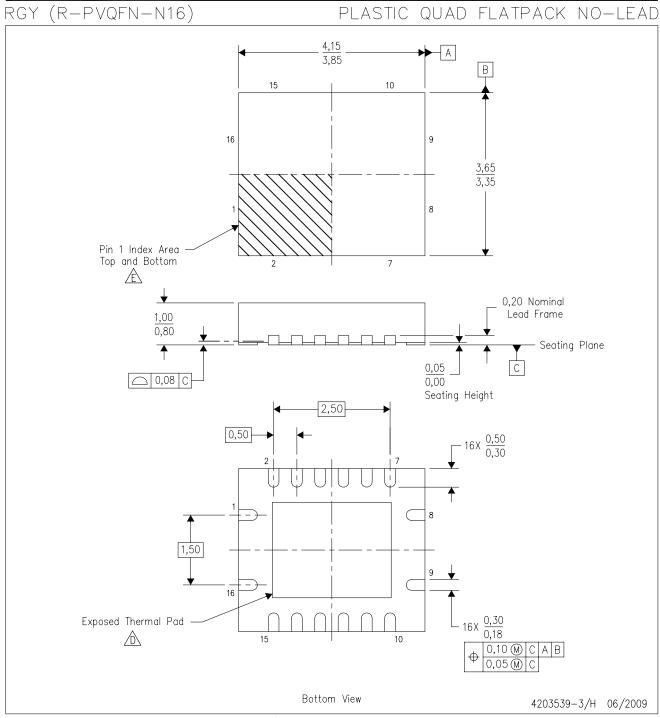


D(R-PDSO-G16)



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Refer to IPC7351 for alternate board design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC—7525
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.





NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) package configuration.
- The package thermal pad must be soldered to the board for thermal and mechanical performance. See the Product Data Sheet for details regarding the exposed thermal pad dimensions.
- Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.
- F. Package complies to JEDEC MO-241 variation BB.



THERMAL PAD MECHANICAL DATA



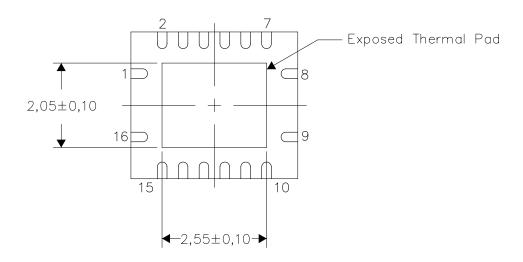
RGY (R-PVQFN-N16)

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No—Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.

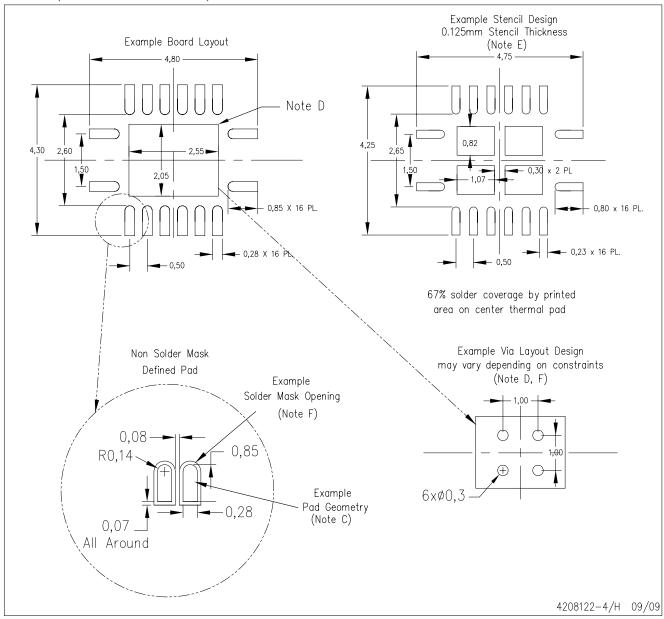


Bottom View

NOTE: All linear dimensions are in millimeters

Exposed Thermal Pad Dimensions

RGY (R-PVQFN-N16)



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat—Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com http://www.ti.com.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



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